## Correlation between structural change and electrical transport

## properties of indium nitride under high pressure

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## Supplementary Information for Publication

Table S1. Values of  $E_g$  and  $dE_g/dP$  for the different candidate phases of InN and the phase transition pressures. B1, B2, and B3 represent the rocksalt, wurtzite, and zinc-blende phase of InN, respectively.

Compound	Phase	Pressure (GPa)	E <sub>g</sub> (eV)		<i>dE<sub>g</sub>/dP</i> (meV/GPa)	
			Present	other	Present	other
			work	calculation	work	calculation
	В3	0		0.0 <sup>a,b,c</sup>		19.94°
				0.02 <sup>d</sup>		16.0 <sup>d</sup>
				0.5813 <sup>e</sup>		
				0.753°, 0.75 <sup>f</sup>		34.0°
	B2	0	0.08		16.5	
				-0.354 <sup>g</sup> , -0.18 <sup>h</sup> ,		23.4 <sup>g</sup>
				-0.160 <sup>i</sup> , -0.118 <sup>g</sup>		
				0.00 <sup>i</sup> , 0.03 <sup>h</sup>		
						21.0 <sup>j</sup>
				0.26 <sup>d</sup> , 0.694 <sup>g</sup>		33.0 <sup>d</sup> , 31.0 <sup>g</sup>
				0.711 <sup>g</sup>		26.1 <sup>g</sup>
				0.772 <sup>i</sup> , 0.805 <sup>g</sup>		34.0 <sup>g</sup>
InN	B1	0		0.0573 <sup>e</sup> , 0.22 <sup>a</sup> , 0.372 <sup>k</sup>		9.4 <sup>e</sup>
				0.6153 °		64.7 <sup>e</sup>
				0.6887 °		
				0.7438 °		44.7 <sup>e</sup>
	B3-B1	10.0		0.00ª, 0.081 <sup>1</sup>		
		10.5 <sup>k</sup>				
		11.84 <sup>m</sup>				
	B2-B1	10.0	0.28		33.0	
		10.2		0.4 <sup>n</sup>		18.0 <sup>n</sup>
		10.86 <sup>m</sup>				

	11.1	0.75 <sup>k</sup>	24.9 <sup>k</sup>
	13.0	0.1803°, 1.3249°, 1.4571°	
	16.0		22.0°
	21.6	1.66 <sup>d</sup>	41.0 <sup>d</sup>

<sup>a</sup>Plane wave self-consistent method with GGA-PBE (Ref. 1).

<sup>b</sup>FP-LAPW method with MBJLDA (modified Becke-Johnson exchange potential+LDA) (Ref. 2).

<sup>c</sup>FPLAPW method with LDA (Ref. 3).

<sup>d</sup>Self-consistent LMTO method with LDA-ASA (Ref. 4).

<sup>e</sup>PAW method with HSE06, GW, and GGA, respectively (Ref. 5).

<sup>f</sup>PW-PP method with LDA+ HGH (Ref. 6).

<sup>g</sup>PAW method with PBE, HSE06, G<sub>0</sub>W<sub>0</sub>(HSE06), scGW<sub>0</sub>, G<sub>0</sub>W<sub>0</sub>(PBE), and GGA, respectively

(Ref. 7).

<sup>h</sup>PAW method with LDA+U (Ref. 8).

<sup>i</sup>PAW method with GGA, GGA+U, and HSE, respectively (Ref. 9).

<sup>j</sup>LAPW method with LDA (Ref. 10).

<sup>k</sup>Troullier-Martins pseudopotentials, DFT-LDA (Ref. 11).

<sup>1</sup>FP-LAPW method with GGA-EV (Ref. 12).

<sup>m</sup>DFT with both LDA and GGA (Ref. 13).

<sup>n</sup>Plane wave pseudopotential with LDA (Ref. 14).

<sup>o</sup>Plane wave basis and with pseudopotentials, LDA+U (Ref. 15).

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